



# International Conference on the Advancement of Silicon Photomultipliers

## Wednesday 13 June 2018

### Nuisance Parameters (14:00-15:30)

**-Conveners: Alberto Gola**

time	[id] title	presenter
14:00	[47] Noise Sources in SiPM	Dr GOLA, Alberto
14:20	[29] Statistical Modeling of SiPM Noise	Dr VINOGRADOV, Sergey
14:40	[48] SiPM Noise Measurements with Waveform Analysis	Mr ENGELMANN, Eugen
15:00	[49] Nuisance Parameters Discussion	Dr GOLA, Alberto

### Nuisance Parameters (16:00-17:40)

**-Conveners: Alberto Gola**

time	[id] title	presenter
16:00	[23] Direct Measurement of Optical Crosstalk in SiPMs Using Light Emission Microscopy	Dr STROM, Derek
16:20	[34] Experimental SiPM Parameter Characterization from Avalanche Triggering Probabilities	Mr GALLINA, Giacomo
16:40	[3] Suppressing Optical Crosstalk in SiPMs	TAJIMA, Hiroyasu
17:00	[51] Simulation of SiPM Noise	Dr BREUER, Johannes
17:20	[50] Nuisance Parameters Discussion & Summary	Dr GOLA, Alberto